Search Notes



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118	729	12/11/2007	Keath Chen
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SEARCH NOTES

Search Notes	Date	Examiner
Inventor search	12/9/2007	Keath Chen
IDS report search	12/9/2007	Keath Chen
Case report To Mike Cleveland	12/6/2007	Keath Chen
Text Search (See EAST search note)	12/11/2007	Keath Chen

INTERFERENCE SEARCH

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